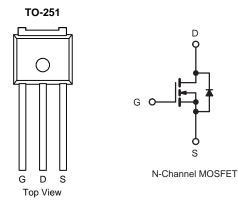


N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A)	Q _g (Typ.)			
30	0.07 at V _{GS} = 10 V	53	19 nC			
	0.09 at V _{GS} = 4.5 V	48	19110			



FEATURES

- Halogen-free
- TrenchFET[®] Gen III Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested •

APPLICATIONS

- DC/DC Conversion
 - System Power



Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	30	V	
Gate-Source Voltage		V _{GS}	± 20		
-	T _C = 25 °C		53		
Continuous Droin Current (T 150 °C)	T _C = 70 °C		41		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	14 ^{b, c}	•	
	T _A = 70 °C		10 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	165		
Avalanche Current	1 0.1 mll	I _{AS}	25		
Avalanche Energy	L = 0.1 mH	E _{AS}	40	mJ	
Cantinuara Causa Daria Diada Currant	T _C = 25 °C		15	А	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	2.9 ^{b, c}	A	
	T _C = 25 °C		28		
Maximum Power Dissipation	T _C = 70 °C	р	18	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	3.5 ^{b, c}	vv	
	T _A = 70 °C		2.2 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150		
Soldering Recommendations (Peak Tempera		260	-0		

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient	t ≤ 10 s	R _{thJA}	29	36	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	3.6	4.5	C/W		

Notes:

a. Based on $T_C = 25 \text{ °C}$. b. Surface Mounted on 1" x 1" FR4 board.

c. t = 10 s.

SPECIFICATIONS $T_J = 25 \text{ °C}$, Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	Symbol	Test conditions		тур.	IVIAA.	Onic
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	30			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$		00	33		- mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 5		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \ \mu A$	1.2	- 0	3.0	V
Gate-Source Leakage		$V_{DS} = 0 V, V_{GS} = \pm 20 V$	1.2		± 100	nA
Gale-Source Leakage	GSS	$V_{DS} = 30 \text{ V}, V_{GS} = 20 \text{ V}$			± 100	IIA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			5	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 V, V_{GS} = 10 V$	15			A
		$V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$	= 10 V, I _D = 10 A 0.070			- Ω
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 7 A				
Forward Transconductance ^a	g _{fs}	V _{DS} = 15 V, I _D = 10 A		24		S
Dynamic ^b		1	I	1	I	
Input Capacitance	C _{iss}			1400		[
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		200		pF
Reverse Transfer Capacitance	C _{rss}			150		
·		$V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 10 \text{ A}$		33		
Total Gate Charge	Qg			18		nC
Gate-Source Charge	Q _{gs}	V _{DS} = 15 V, V _{GS} = 4.5 V, I _D = 10 A		7.3		
Gate-Drain Charge	Q _{gd}			6.2		
Gate Resistance	R _g	f = 1 MHz	0.2	0.8	1.6	Ω
Turn-On Delay Time	t _{d(on)}			15	30	
Rise Time	t _r	V _{DD} = 15 V, R _I = 1.5 Ω		12	24	-
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, \text{ V}_{\text{GEN}} = 4.5 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		13	26	
Fall Time	t _f	-		10	20	
Turn-On Delay Time	t _{d(on)}			9	18	ns
Rise Time	t _r	V _{DD} = 15 V, R _I = 1.5 Ω		9	18	-
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, \text{ R}_g = 1 \Omega$		14	28	
Fall Time	t _f	-		8	16	
Drain-Source Body Diode Characteristic	s	l			1	1
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			16	^
Pulse Diode Forward Current	I _{SM}				32	A
Body Diode Voltage	V _{SD}	I _S = 3 A, V _{GS} = 0 V		0.78	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			17	34	ns
Body Diode Reverse Recovery Charge	Q _{rr}			9.5	19	nC
Reverse Recovery Fall Time	ta	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		10		
Reverse Recovery Rise Time	t _b			7	1	ns

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

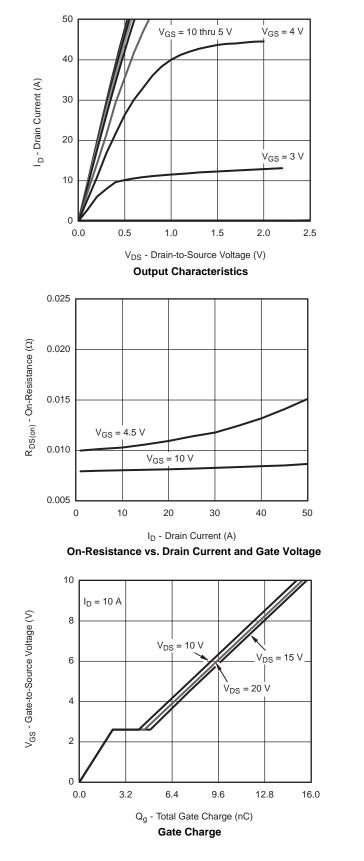
b. Guaranteed by design, not subject to production testing.

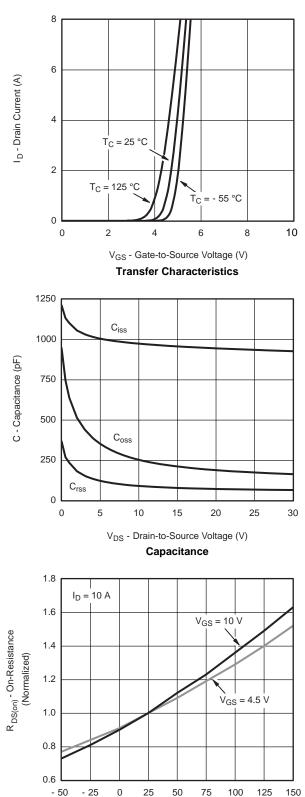
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

emi

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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

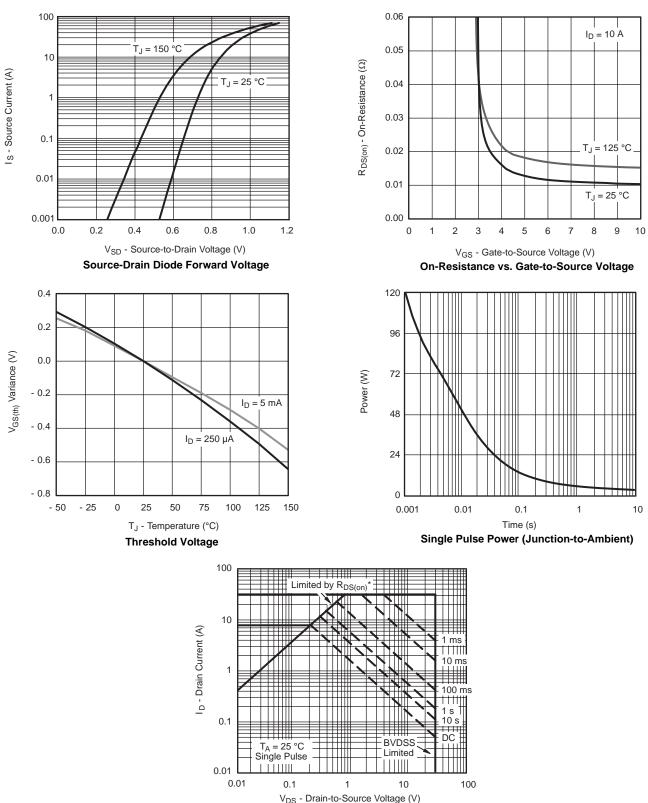




T_J - Junction Temperature (°C)

On-Resistance vs. Junction Temperature



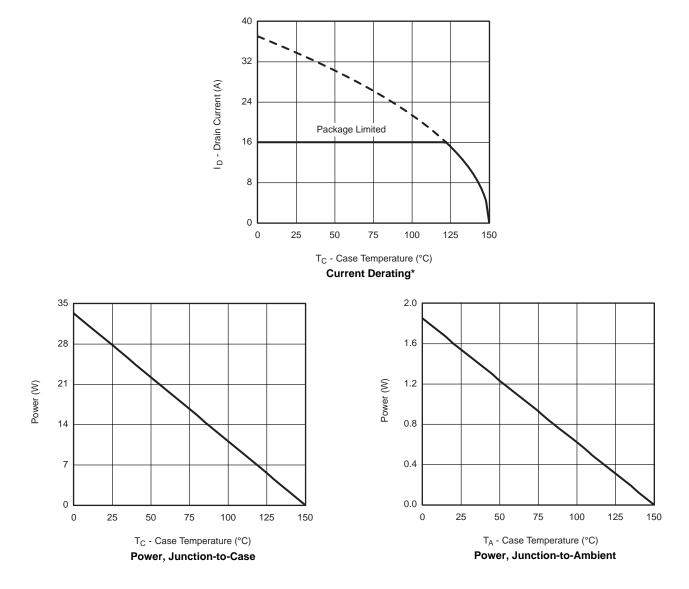


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

* V_{GS} > minimum V_{GS} at which R_{DS(on)} is specified Safe Operating Area, Junction-to-Ambient



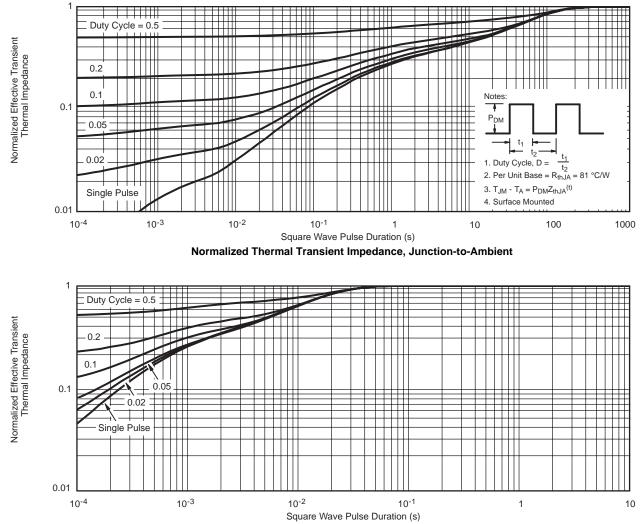
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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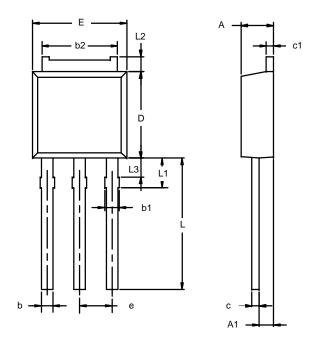
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Case



TO-251AA (DPAK)



Note: Dimension L3 is for reference only.

	MILLIN	IETERS	INC	HES	
Dim	Min	Max	Min	Max	
Α	2.21	2.38	0.087	0.094	
A1	0.89	1.14	0.035	0.045	
b	0.71	0.89	0.028	0.035	
b1	0.76	1.14	0.030	0.045	
b2	5.23	5.43	0.206	0.214	
С	0.46	0.58	0.018	0.023	
c1	0.46	0.58	0.018	0.023	
D	5.97	6.22	0.235	0.245	
Е	6.48	6.73	0.255	0.265	
е	2.28 BSC		0.090 BSC		
L	3.89	9.53	0.153	0.375	
L1	1.91	2.28	0.075	0.090	
L2	0.89	1.27	0.035	0.050	
L3	1.15	1.52	0.045	0.060	
ECN: S-03946—Rev. E, 09-Jul-01 DWG: 5346					



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